

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	26743	"708"/\$.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:02
L2	5850	interval\$1 and 1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:03
L3	147	inequal\$5 and 2	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:03
L4	29	box\$2 and 3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:03
L5	13	4 and @ad<"20011213"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:06
L6	1530	(interval\$1.ti. or interval\$1.clm. or interval\$1.ab.) and "708"/\$.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:05
L7	148	6 and (box\$2 or sub-box\$2 or (sub adj box\$2))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:05
L8	119	7 and @ad<"20011213"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:06

L9	110	8 not william.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:06
L10	12	optimiz\$5 and 9	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/04/26 16:06



Welcome United States Patent and Trademark Office

☐ Search Results

[BROWSE](#)
[SEARCH](#)
[IEEE XPLORE GUIDE](#)

Results for "((interval <and> box <and> constraint)<in>metadata)"

☐ e-mail

Your search matched 8 of 1152881 documents.

A maximum of 100 results are displayed, 25 to a page, sorted by Relevance in Descending order.

» [View Session History](#)» [New Search](#)» [Key](#)

Modify Search

☐ Check to search only within this results set
Display Format: ☒ Citation ☐ Citation & Abstract

IEEE JNL IEEE Journal or Magazine

IEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEE CNF IEE Conference Proceeding

IEEE STD IEEE Standard

Select Article Information

- ☐ 1. **Box consistency through weak box consistency**
 Granvilliers, L.; Goulard, F.; Benhamou, F.;
 Tools with Artificial Intelligence, 1999. Proceedings. 11th IEEE International Conference 9-11 Nov. 1999 Page(s):373 - 380
[AbstractPlus](#) | Full Text: [PDF\(136 KB\)](#) IEEE CNF
- ☐ 2. **Automatic test data generation for programs with integer and float variables**
 Sy, N.T.; Deville, Y.;
 Automated Software Engineering, 2001. (ASE 2001). Proceedings. 16th Annual International Conference on 26-29 Nov. 2001 Page(s):13 - 21
[AbstractPlus](#) | Full Text: [PDF\(868 KB\)](#) IEEE CNF
- ☐ 3. **Test sequences generation from LUSTRE descriptions: GATEL**
 Marre, B.; Arnould, A.;
 Automated Software Engineering, 2000. Proceedings ASE 2000. The Fifteenth IEEE International Conference on 11-15 Sept. 2000 Page(s):229 - 237
[AbstractPlus](#) | Full Text: [PDF\(648 KB\)](#) IEEE CNF
- ☐ 4. **Globally convergent autocalibration**
 Benedetti, A.; Busti, A.; Farenzena, M.; Fusiello, A.;
 Computer Vision, 2003. Proceedings. Ninth IEEE International Conference on 13-16 Oct. 2003 Page(s):1426 - 1432 vol.2
[AbstractPlus](#) | Full Text: [PDF\(396 KB\)](#) IEEE CNF
- ☐ 5. **An interval method for global nonlinear analysis**
 Kolev, L.;
 Circuits and Systems I: Fundamental Theory and Applications, IEEE Transactions on [and Systems I: Regular Papers, IEEE Transactions on] Volume 47, Issue 5, May 2000 Page(s):675 - 683
[AbstractPlus](#) | [References](#) | Full Text: [PDF\(184 KB\)](#) IEEE JNL
- ☐ 6. **The posterior probabilities of linearly constrained priors and interval-bounded covariance**
 Snow, P.;
 Systems, Man and Cybernetics, Part A, IEEE Transactions on Volume 26, Issue 5, Sept. 1996 Page(s):655 - 659

[AbstractPlus](#) | [References](#) | Full Text: [PDF\(452 KB\)](#) IEEE JNL

7. **Robust Schur stability of interval polynomials**
Kraus, F.; Mansour, M.; Jury, E.I.;
Automatic Control, IEEE Transactions on
Volume 37, Issue 1, Jan. 1992 Page(s):141 - 143

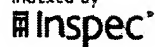
[AbstractPlus](#) | Full Text: [PDF\(248 KB\)](#) IEEE JNL

8. **A linear programming approach to controller design**
Keel, L.H.; Bhattacharyya, S.P.;
Decision and Control, 1997., Proceedings of the 36th IEEE Conference on
Volume 3, 10-12 Dec. 1997 Page(s):2139 - 2148 vol.3

[AbstractPlus](#) | Full Text: [PDF\(684 KB\)](#) IEEE CNF



Indexed by



[Help](#) [Contact Us](#) [Privacy &](#)

© Copyright 2005 IEEE –